



FCC RF Test Report

Product Name: LTE/UMTS Smart Phone; HUAWEI Ascend G6

Model Number: HUAWEI G6-L33, G6-L33

Report No: SYBH(Z-RF)09022014-2001

FCC ID: QISG6-L33

Reliability Laboratory of Huawei Technologies Co., Ltd.

Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

Tel: +86 755 28780808 Fax: +86 755 89652518



Notice

- 1. The laboratory has Passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
- 2. The laboratory has Passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
- 3. The laboratory has been listed by the US Federal Communications Commission to perform electromagnetic emission measurements. The site recognition number is 97456.
- 4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-2.
- 5. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 6. The test report is invalid if there is any evidence of erasure and/or falsification.
- 7. The test report is only valid for the test samples.
- 8. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.



Applicant: Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

Date of Receipt Sample: 2014-02-25
Start Date of Test: 2014-02-25
End Date of Test: 2014-02-28

Test Result: Pass

Approved by Senior 2014-03-11 Dai Linjun

Engineer: Date Name Signature

Prepared by: 2014-03-11 Feng Nianwei

Date Name Signature



Modification Record

No.	Last Report No.	Modification Description	
1		First report.	



CONTENT

1	Gene	eral Information	6
	1.1	Applied Standard	6
	1.2	Test Location	6
	1.3	Test Environment Condition	6
2	Test	Summary	7
	2.1	Cellular Band (824-849 MHz paired with 869-894 MHz)	7
	2.2	PCS Band (1850-1915 MHz paired with 1930-1995 MHz)	8
	2.3	AWS Band (1710-1755 MHz paired with 2110-2155 MHz)	g
3	Desc	cription of the Equipment under Test (EUT)	10
	3.1	General Description	10
	3.2	EUT Identity	12
	3.3	Technical Specification	13
4	Gene	eral Test Conditions / Configurations	14
	4.1	Test Modes	14
	4.2	Test Environment	14
	4.3	Test Frequency	15
	4.4	DESCRIPTION OF TESTS	19
	4.5	Test Setups	22
	4.6	Test Conditions	24
5	Main	Test Instruments	26
6	Meas	surement Uncertainty	27



1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 02:2012

47 CFR FCC Part 22: 2012 47 CFR FCC Part 24: 2012 47 CFR FCC Part 27: 2012

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v01

1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C

Ambient Relative Humidity: 40 to 55 %

Atmospheric Pressure: Not applicable



2 Test Summary

2.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

Test Item	FCC Rule	Requirements	Test Result	Verdict
	No.			
Effective (Isotropic) Radiated	§2.1046,	ERP ≤ 7 W.	A A	Pass
Power Output Data	§22.913	ERF > 1 VV.	Appendix A	F455
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit.	A D	Pass
Danuwiutii	92.1049	EBW: No limit.	Appendix D	
	§2.1051,	≤ -13 dBm/1%*EBW, in 1 MHz bands		
Band Edges Compliance	§2.1031, §22.917	immediately outside and adjacent to	Appendix E	Pass
	922.917	the frequency block.		
		\leq -13 dBm/100 kHz, from 9 kHz to		
Spurious Emission at Antenna	§2.1051,	10 th harmonics but outside	Appendix F	Pass
Terminals	§22.917	authorized operating frequency	Appendix F	Fa55
		ranges.		
Field Strength of Spurious	§2.1053,	≤ -13 dBm/100 kHz.	Appendix C	Pass
Radiation	§22.917	≥ -13 UDIII/ 100 KHZ.	Appendix G	rass
§2.105		C ±2 5ppm	Appendix H	Door
Frequency Stability	§22.355	≤ ±2.5ppm.	Appendix H	Pass



2.2 PCS Band (1850-1915 MHz paired with 1930-1995 MHz)

Test Item FCC		Requirements	Test Result	Verdict
	Rule No.			
Effective (Isotropic) Radiated	§2.1046,	EIRP ≤ 2 W	Appendix A	Pass
Power Output Data	§24.232			
Dook Average Petie	§2.1046,	Limit≤13 dB	Appendix B	Pass
Peak-Average Ratio	§24.232	LITTILS 13 UB		
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit.	Appendix D	Pass
		EBW: No limit.		
Band Edges Compliance	§2.1051,	≤ -13 dBm/1%*EBW, in 1 MHz bands	Appendix E	Pass
	§24.238	immediately outside and adjacent to		
		the frequency block.		
Spurious Emission at Antenna	§2.1051,	\leq -13 dBm/1 MHz, from 9 kHz to 10 th	Appendix F	Pass
Terminals	§24.238	harmonics but outside authorized		
		operating frequency ranges.		
Field Strength of Spurious §2.1053		≤ -13 dBm/1 MHz.	Appendix G	Pass
Radiation	§24.238			
Frequency Stability	§2.1055,	FCC: within authorized frequency	Appendix H	Pass
	§24.235	block.		



2.3 AWS Band (1710-1755 MHz paired with 2110-2155 MHz)

Test Item	FCC	Requirements	Test Result	Verdict
	Rule No.			
Effective (Isotropic) Radiated	§2.1046,	EIRP ≤ 1 W;	Appendix A	Pass
Power Output Data	§27.50(d)			
Peak-Average Ratio	§2.1046,	Limit≤13 dB	Appendix B	Pass
reak-Average Natio	§27.50(d)	LITHE 13 UB		
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit.	Appendix D	Pass
		EBW: No limit.		
Band Edges Compliance	§2.1051,	≤ -13 dBm/1%*EBW, in 1 MHz bands	Appendix E	Pass
	§27.53(h)	immediately outside and adjacent to		
		the frequency block.		
Spurious Emission at Antenna	§2.1051,	\leq -13 dBm/1 MHz, from 9 kHz to 10 th	Appendix F	Pass
Terminals	§27.53(h)	harmonics but outside authorized		
		operating frequency ranges.		
Frequency Stability	§2.1055,	Within authorized bands of	Appendix G	Pass
	§27.54	operation/frequency block.		
Radiated spurious emission §2.1053,		≤ -13 dBm/1 MHz.	Appendix H	Pass
	§27.53(h)			



3 Description of the Equipment under Test (EUT)

3.1 General Description

HUAWEI G6-L33, G6-L33 is subscriber equipment in the LTE/WCDMA/GSM system. The HSPA/UMTS frequency band is Band I and Band II and Band V and Band IV. The LTE frequency band is B2 and B7 and B4. The GSM/GPRS/EDGE frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900, but only WCDMA850 and W1900 and W1700 and LTE B2 and LTE B4 bands test data included in this report. The Mobile Phone implements such functions as RF signal receiving/transmitting, LTE/HSPA/UMTS and GSM/GPRS/EDGE protocol processing, voice, video MMS service, GPS, AGPS, NFC and WIFI etc. Externally it provides micro SD card interface, earphone port (to provide voice service) and USIM card interface. It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

NOTE: The mobile phone G6-L11 and G6-L33 are LTE/UMTS mobile phone with Bluetooth.

The differences among G6-L11 and G6-L33 are showed in the following table.

	G6-L11	G6-L33
GSM four bands	GMS850/900/1800/1900	the same
WCDMA bands	B1/B8	B1/B2/B4/B5
LTE bands	B3/B7/B20	B2/B4/B7
FLASH	the same	the same
Main board	With NFC RF circuit	the same
Appearance	the same	the same
NFC	support	support
Bluetooth mode	the same	the same
WLAN mode	the same	the same
BT/ WLAN antenna	the same	the same
GSM/ WCDMA antenna	the same	the same
External camera	the same	the same
internal camera	the same	the same
Adapter	the same	the same
Battery	the same	the same
Chipset	the same	the same
Memory	the same	the same



Form factor	Bar type, Internal antenna	the same
RF Parameter	The same RF Parameter in the same band	The same RF Parameter in the same band
BT RF Parameter	the same	the same
Dimension	the same	the same
Weight	the same	the same
External camera	the same	the same
Main Frequency NV	The same NV in the same band	The same NV in the same band

So The GSM850 and GSM1900 test cases refer to **NO. SYBH(Z-RF)012012014-2001** of G6-L11 RF report. The LTE BAND7 test cases refer to **NO. SYBH(Z-RF)012012014-2001** of G6-L11 RF report. The WLAN test cases refer to **NO. SYBH(Z-RF)012012014-2002** of G6-L11 RF report. The Bluetooth test cases refer to **NO. SYBH(Z-RF)012012014-2003** of G6-L11 RF report. The Bluetooth BLE test cases refer to **NO. SYBH(Z-RF)012012014-2004** of G6-L11 RF report. The NFC test cases refer to **NO. SYBH(Z-RF)012012014-2005** of G6-L11 RF report.



3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 Board

Board				
Description	Hardware Version	Software Version		
Main Board	HL1G6L22M	G6-L33V100R001C00B105		



3.3 Technical Specification

Characteristics	Description		
Radio System Type	☑ UMTS☑ LTE		
Supported Frequency Range	0011050/11/001111050	Transmission (TX): 824 to 849 MHz	
	GSM850/ WCDMA850	Receiving (RX): 869 to 894 MHz	
	00044000/14/0000	Transmission (TX): 1850 to 1910 MHz	
	GSM1900/ WCDMA1900	Receiving (RX): 1930 to 1990 MHz	
	WODMA 4700	Transmission (TX): 1710 to 1755 MHz	
	WCDMA1700	Receiving (RX): 2110 to 2155 MHz	
	LTE BAND4	Transmission (TX): 1710 to 1755 MHz	
		Receiving (RX): 2110 to 2155 MHz	
	LTE BAND7	Transmission (TX): 2500 to 2570 MHz	
		Receiving (RX): 2620 to 2690 MHz	
TX and RX Antenna Ports	TX & RX port:	1	
	TX-only port:	0	
	RX-only port:	1	
Target TX Output Power	UMTS850 23.5dBm		
	UMTS1900: 23.5dBm		
	UMTS1700 23.5dBm		
	LTE system: 23dBm		
Supported Channel Bandwidth	UMTS system:	⊠ 5 MHz	
	LTE band 2		
		MHz,⊠ 15 MHz, ⊠ 20 MHz	
	LTE band 4		
		MHz,⊠ 15 MHz, ⊠ 20 MHz	
	LTE band 7	∑ 5 MHz,	
		MHz	
Designation of Emissions	UMTS850:	4M17F9W	
(Note: the necessary bandwidth of	UMTS1900:	4M22F9W	
which is the worst value from the	UMTS1700:	4M17F9W	
measured occupied bandwidths for	LTE BAND2:	1M09G7D (1.4 MHz QPSK modulation),	
each type of channel bandwidth		1M09W7D (1.4 MHz 16QAM modulation)	
configuration.)		2M70G7D (3 MHz QPSK modulation),	
		2M70W7D (3 MHz 16QAM modulation)	
		4M50G7D (5 MHz QPSK modulation),	
		4M51W7D (5 MHz 16QAM modulation)	
		8M98G7D (10 MHz QPSK modulation),	
		8M97W7D (10 MHz 16QAM modulation)	
		13M5G7D (15 MHz QPSK modulation),	
		13M5W7D (15 MHz 16QAM modulation)	
		18M0G7D (20 MHz QPSK modulation),	
		18M0W7D (20 MHz 16QAM modulation)	



Characteristics	Description	
	LTE BAND4:	1M09G7D (1.4 MHz QPSK modulation),
		1M09W7D (1.4 MHz 16QAM modulation)
		2M70G7D (3 MHz QPSK modulation),
		2M70W7D (3 MHz 16QAM modulation)
		4M51G7D (5 MHz QPSK modulation),
		4M51W7D (5 MHz 16QAM modulation)
		9M00G7D (10 MHz QPSK modulation),
		8M97W7D (10 MHz 16QAM modulation)
		13M5G7D (15 MHz QPSK modulation),
		13M5W7D (15 MHz 16QAM modulation)
		18M0G7D (20 MHz QPSK modulation),
		18M0W7D (20 MHz 16QAM modulation)

4 General Test Conditions / Configurations

4.1 Test Modes

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

Test Mode	Test Modes Description	
UMTS/TM1	WCDMA system, QPSK modulation	
UMTS/TM2	HSDPA system, QPSK modulation	
UMTS/TM3	HSUPA system, QPSK modulation	
LTE/TM1	LTE system, QPSK modulation	
LTE/TM2	LTE system, 16QAM modulation	

4.2 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
	VL	3.6V
Voltage	VN	3.8V
	VH	4.35V

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



4.3 Test Frequency

	TX/RX	RF Channel					
Test Mode		Low (L)	Middle (M)	High (H)			
	_,,	Channel 4132	Channel 4182	Channel 4233			
WCDMA850	TX	826.4MHz	836.4MHz	846.6MHz			
WCDIVIA850	RX	Channel 4357	Channel 4407	Channel 4458			
	KA	871.4MHz	881.4MHz	891.6MHz			
Test Mode	TV / DV		RF Channel				
r est Mode	TX/RX	Low (L)	Middle (M)	High (H)			
	TX RX	Channel 9262	Channel9400	Channel9538			
WCDMA1900		1852.4MHz	1880.0MHz	1907.6MHz			
WCDIVIA 1900		Channel 9662	Channel 9800	Channel 9938			
		1932.4 MHz	1960.0 MHz	1987.6 MHz			
Test Mode	TX / RX	RF Channel					
r est Mode		Low (L)	Middle (M)	High (H)			
	TX	Channel1312	Channel1413	Channel1513			
WODAN (====		1712.4MHz	1732.6MHz	1752.6MHz			
WCDMA1700	RX	Channel 1537	Channel 1638	Channel 1738			
	KΛ	2112.4 MHz	2132.6 MHz	2152.6 MHz			



Test Mode	TX / RX	RF Channel			
rest Mode		Low (B)	Middle (M)	High (T)	
	TV(4, 40.0)	Channel 18607	Channel 18900	Channel 19193	
	TX(1.4M)	1850.7MHz	1880 MHz	1909.3 MHz	
	TX(3M)	Channel 18615	Channel 18900	Channel 19185	
	1 \(\(3\)\(\)	1851.5MHz	1880 MHz	1908.5 MHz	
	TX(5M)	Channel 18625	Channel 18900	Channel 19175	
	1 \(\(\(\)\(\)\(\)	1852.5 MHz	1880 MHz	1907.5 MHz	
	TX(10M)	Channel 18650	Channel 18900	Channel 19150	
	TX(TOM)	1855 MHz	1880 MHz	1905 MHz	
	TY(15M)	Channel 18675	Channel 18900	Channel 19125	
	TX(15M)	1857.5 MHz	1880 MHz	1902.5 MHz	
	TX(20M)	Channel 18700	Channel 18900	Channel 19100	
LTE Band 2		1860 MHz	1880 MHz	1900 MHz	
	RX(1.4M)	Channel 607	Channel 900	Channel 1193	
		1930.7 MHz	1960 MHz	1989.3 MHz	
	RX(3M)	Channel 615	Channel 900	Channel1185	
		1931.5 MHz	1960 MHz	1988.5 MHz	
	RX(5M)	Channel 625	Channel 900	Channel 1175	
	KX(SIVI)	1932.5 MHz	1960 MHz	1987.5 MHz	
	RX(10M)	Channel 650	Channel 900	Channel 1150	
	TCA(TOIVI)	1935 MHz	1960 MHz	1985 MHz	
	RX(15M)	Channel 675	Channel 900	Channel 1125	
	TCA(TOIVI)	1937.5 MHz	1960 MHz	1982.5 MHz	
	RX(20M)	Channel 700	Channel 900	Channel 1100	



Test Mode	TX / RX	RF Channel		
rest wode	IA/RA	Low (B)	Middle (M)	High (T)
		1940 MHz	1960 MHz	1980 MHz

	TX/RX	RF Channel			
Test Mode		Low (B)	Middle (M)	High (T)	
	TV (4.4M)	Channel 19957	Channel 20175	Channel 20393	
	TX (1.4M)	1710.7 MHz	1732.5 MHz	1754.3 MHz	
	TX (3M)	Channel 19965	Channel 20175	Channel 20385	
	17 (3141)	1711.5 MHz	1732.5 MHz	1753.5 MHz	
	TX (5M)	Channel 19975	Channel 20175	Channel 20375	
	17 (3141)	1712.5 MHz	1732.5 MHz	1752.5 MHz	
	TX (10M)	Channel 20000	Channel 20175	Channel 20350	
	TX (TOW)	1715 MHz	1732.5 MHz	1750 MHz	
	TX (15M)	Channel 20025	Channel 20175	Channel 20325	
LTE Band 4		1717.5 MHz	1732.5 MHz	1747.5 MHz	
LIL Band 4	TX (20M)	Channel 20050	Channel 20175	Channel 20300	
		1720 MHz	1732.5 MHz	1745 MHz	
	RX (1.4M)	Channel 1957	Channel 2175	Channel 2393	
		2110.7 MHz	2132.5 MHz	2154.3 MHz	
	RX (3M)	Channel 1965	Channel 2175	Channel 2385	
	TCX (SIVI)	2111.5 MHz	2132.5 MHz	2153.5 MHz	
	RX (5M)	Channel 1975	Channel 2175	Channel 2375	
	TCA (SIVI)	2112.5 MHz	2132.5 MHz	2152.5 MHz	
	RX (10M)	Channel 2000	Channel 2175	Channel 2350	
	TCX (TOWI)	2115 MHz	2132.5 MHz	2150 MHz	



Test Mode	TX/RX	RF Channel			
		Low (B)	Middle (M)	High (T)	
	DV (45M)	Channel 2025	Channel 2175	Channel 2325	
	RX (15M)	2117.5 MHz	2132.5 MHz	2147.5 MHz	
	RX (20M)	Channel 2050	Channel 2175	Channel 2300	
		2120 MHz	2132.5 MHz	2145 MHz	



4.4 DESCRIPTION OF TESTS

4.4.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-C-2004. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

Pd [dBm] = Pg [dBm] - cable loss [dB] + antenna gain [dBd/dBi]

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]).

Note: Reference test setup 3



4.4.2 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1.

4.4.3 Spurious and Harmonic Emissions at Antenna Terminal

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1.

4.4.4 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1.



4.4.5 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

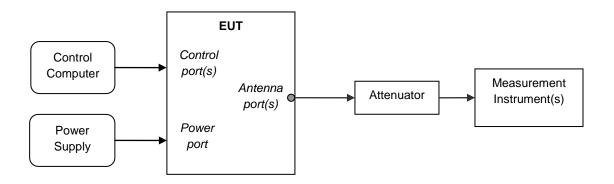
- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 2.

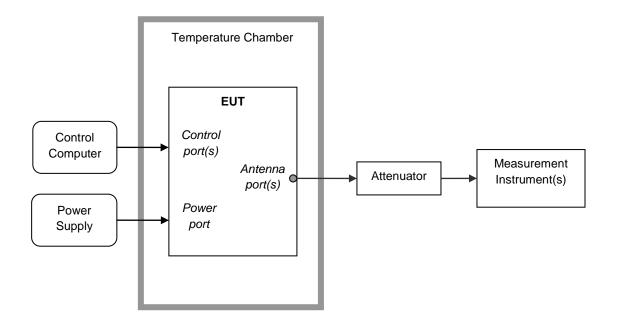


4.5 Test Setups

4.5.1 Test Setup 1



4.5.2 Test Setup 2

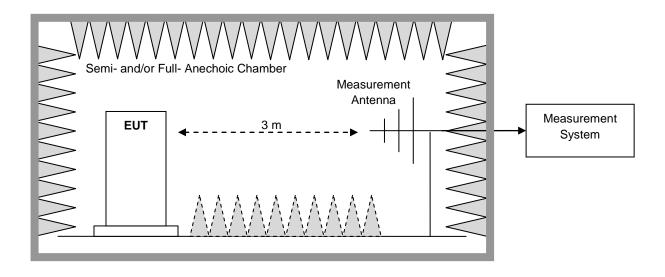




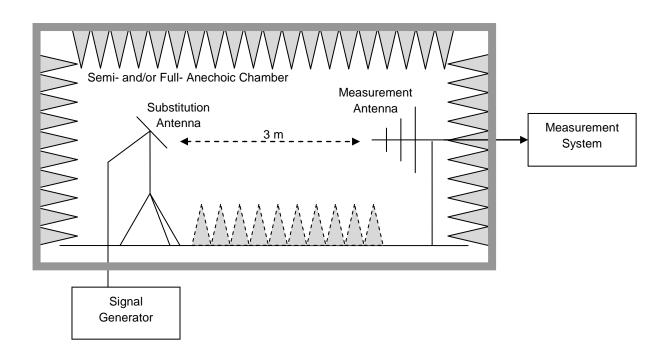
4.5.3 Test Setup 3

NOTE: Effective radiated power (ERP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

4.5.3.1 Step 1: Pre-test



4.5.3.2 Step 2: Substitution method to verify the maximum ERP





4.6 Test Conditions

Test Case		Test Conditions		
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
Output	Total	Test Setup	Test Seup 1	
Power Data		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
	Spectral Density	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
	Peak-to-Average	Test Env.	Ambient Climate & Rated Voltage	
	Ratio	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
Modulation C	haracteristics	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Seup 1	
		RF Channels	M	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
Bandwidth Occupied		Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
	Emission	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
Band Edges	Compliance	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
Spurious Em	Spurious Emission at Antenna Test E		Ambient Climate & Rated Voltage	
RF		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	



Test Case	Test Conditions		
	Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage	
Radiation	Test Setup	Test Seup 3	
	Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	
		NOTE: If applicable, the EUT conf. that has maximum power	
		density (based on the equivalent power level) is	
		selected.	
	RF Channels	L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel)	
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;	
		(2) 85%, 100% and 115% of Rated Voltage at Ambient Climate.	
	Test Setup	Test Seup 2	
RF Channels L, M, H		L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel)	
	Test Mode	UMTS/TM1,LTE/TM1,LTE/TM2	



5 <u>Main Test Instruments</u>

Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal- Due
Power supply	KEITHLEY	2303	1288003	2012-11-19	2014-11-18
Wireless Communication Test set	Agilent	N4010A	MY49081592	2013-10-29	2014-10-28
Universal Radio Communication Tester	R&S	CMU200	113164	2013-07-18	2014-07-17
Universal Radio Communication Tester	R&S	CMW500	126855	2013-08-08	2015-08-09
Spectrum Analyzer	Agilent	E4440A	MY48250119	2013-08-09	2014-08-08
Signal Analyzer	R&S	FSQ31	200021	2013-10-29	2014-10-28
Spectrum Analyzer	Agilent	N9030A	MY49431698	2013-10-29	2014-10-28
Temperature Chamber	ESPEC	MW3030	06114003	2013-05-14	2014-05-13
Signal generator	Agilent	E8257D	MY51500314	2013-04-15	2014-04-14
Vector Signal Generator	R&S	SMU200A	104162	2013-10-29	2014-10-28
Test receiver	R&S	ESU26	100150	2013-05-15	2014-05-14
Spectrum analyzer	R&S	FSU3	200474	2013-12-24	2014-12-23
Spectrum analyzer	R&S	FSU43	100144	2013-12-24	2014-12-23
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2013-02-02	2015-02-01
Trilog Broadband Antenna (30M~3GHz)	SCHWARZB ECK	VULB 9163	9163-490	2013-02-02	2015-02-01
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100262	2013-03-23	2015-03-22
Pyramidal Horn Antenna(18GHz-26-5GHz)	ETS-LINDG REN	3160-09	5140299	2013-03-05	2015-03-04
Artificial Mains Network	R&S	ENV4200	100134	2013-12-24	2014-12-23
Artificial Mains Network	R&S	ENV216	100382	2013-12-24	2014-12-23



6 <u>Measurement Uncertainty</u>

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	
Transmit Output Power Data	Power [dBm]	U = 0.39 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 2.0 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
		For 10 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.21 ppm

END